

TLDR: We describe the asymptotic distribution of SGD in nonconvex problems through a large deviation approach

Problem of interest

 $\underset{x \in \mathbb{R}^d}{\operatorname{minimize}} f(x)$

Stochastic Gradient Descent (SGD):

 $x_{t+1} = x_t - \eta \left| \nabla f(x_t) + Z(x_t; \omega_t) \right|$

Basic assumptions:

• f is β -smooth: $\|\nabla f(x) - \nabla f(x')\| \le \beta \|x - x'\|$ for all x, x'

• f is coercive: $\lim_{\|x\|\to\infty} f(x) = +\infty$

Critical points

SGD spends most of its time on average near critical points $\operatorname{crit}(f) = \{x \in \mathbb{R}^d \mid \nabla f(x) = 0\}$

Q: Which critical points are more likely to be visited by SGD and by how much?

Regularity assumption:

 $\bigcup K_i$, where K_i (smoothly) connected components $\operatorname{crit}(f) = [$

Invariant measure

Invariant measure: probability measure μ_{∞} on \mathbb{R}^d such that

$$\sim \mu_{\infty} \qquad \Rightarrow \qquad x_{t+1} \sim \mu_{\infty}$$

 \rightarrow weak- \star limit points of the mean occupation measures of the iterates of SGD:

$$\mu_{n(\mathcal{B})} = \mathbb{E}\left[\frac{1}{n}\sum_{t=1}^n \mathbf{1}\{x_t \in \mathcal{B}\}\right]$$

Q: Where do invariant measures of SGD concentrate?

Noise assumptions: • $\mathbb{E}[Z(x;\omega)] = 0$, $\operatorname{cov}(Z(x;\omega)) \succ 0$, $Z(x;\omega) = O(||x||)$ almost surely • $Z(x;\omega)$ is σ sub-Gaussian: $\log \mathbb{E} \left[e^{\langle v, Z(x;\omega) \rangle} \right] \leq \frac{\sigma^2}{2} \|v\|^2$ • SNR high enough: $\liminf_{\|x\|\to\infty} \frac{\|\nabla f(x)\|^2}{\sigma^2}$ larger than some constant

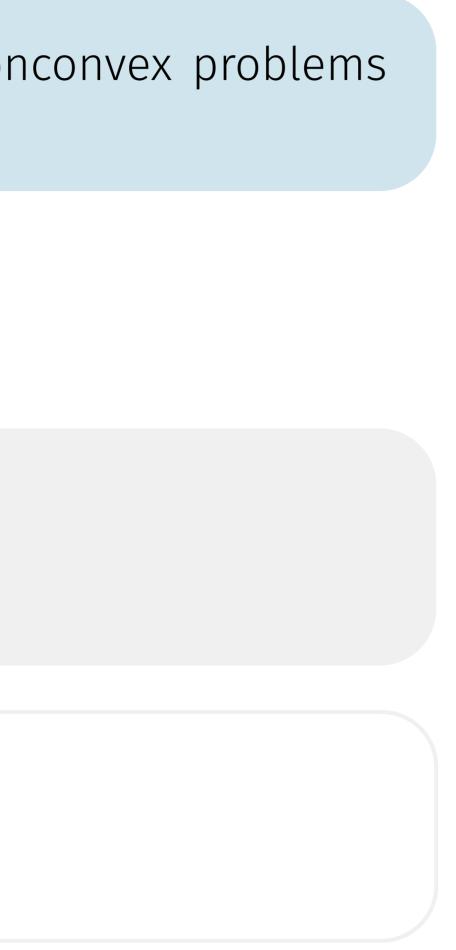
Example (Finite-sum):

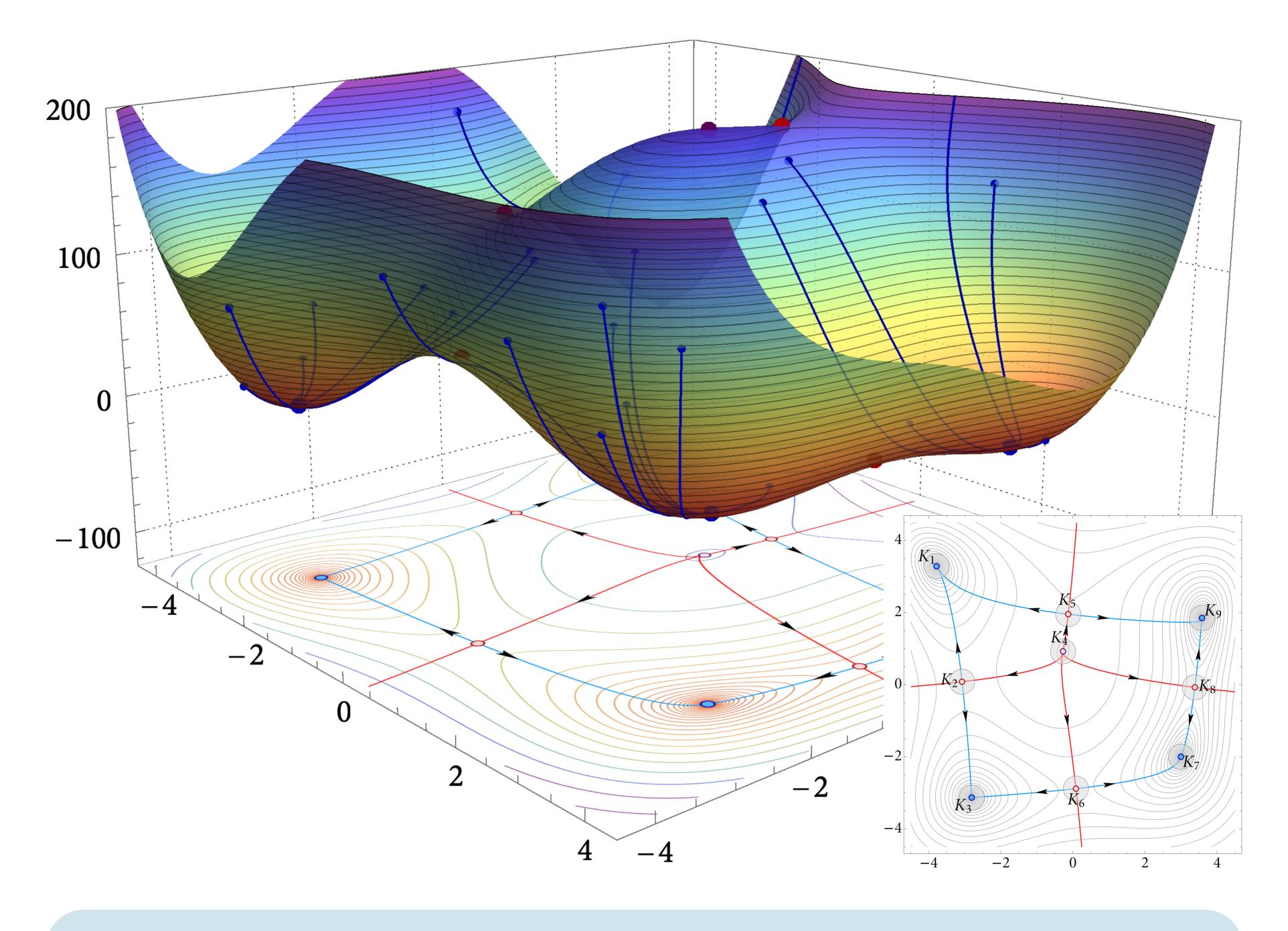
 $f(x) = \frac{1}{n} \sum_{i=1}^{n} f_i(x) + \frac{\lambda}{2} \|x\|^2$ with f_i Lipschitz and smooth; $Z(x;\omega) = \nabla f_{\omega}(x) - \nabla f(x)$



What is the Long-Run Distribution of SGD? A Large Deviation Analysis

W. Azizian, F. Iutzeler, J. Malick, P. Mertikopoulos





Main results:

- centrated near the critical points of f
- 2. Saddle-point avoidance: Non-minimizing critical points are exponentially less likely to be observed than local minimizers
- . Boltzmann-Gibbs distribution: The probability of observing a critical point is exponentially proportional to its energy (not its value)
- 4. Ground state concentration: The iterates of SGD are exponentially more likely to be observed near its ground state (set of minimum energy)

Challenges and techniques:

- No known approach to analyze the asymptotic distribution of SGD in non-convex problems e.g. SDE approximations only valid on finite time horizons
- We leverage large deviation theory and the theory of random dynamical systems, \rightarrow Estimate the probability of rare events, such as SGD escaping a local minima
- We adapt the theory of Freidlin & Wentzell (1998); Kifer (1988) to SGD with two main challenges: a) Lack of compactness
- b) Realistic noise models (finite sum)
- ightarrow Remedy these issues by refining the analysis

References

Freidlin, M. I., & Wentzell, A. D., 2012. Random perturbations of dynamical systems. Springer Kifer, Y., 1988. Random perturbations of dynamical systems. Birkhäuser

1. Concentration near critical points: The iterates of SGD are exponentially con-

Noise statistics:

Cumulant generating funct

Lagrangian:

Lemma (Large deviations for SGD)

This means: for $\eta > 0$ small enough, for any trajectory $\gamma : [0,T] \to \mathbb{R}^d$,

Example (Gaussian noise)

Proposition (Transition probability)

Transition probability from K_i to K_j :

where $B_{i,j}$ transition cost

Technical assumption: $B_{i,j} < +\infty$ for all i, j

Energy of K_i :

Theorem (Invariant measure of SGD)

- 2. Boltzmann-Gibbs distribution: for all *i*,





ttion of
$$Z(x;\omega)$$
:
 $\mathcal{H}(x,v) = \log \mathbb{E} \left[e^{\langle v, Z(x;\omega) \rangle} \right]$
 $\mathcal{L}(x,v) = \mathcal{H}^*(x, -v - \nabla f(x)))$

SGD admits a large deviation principle as $\eta
ightarrow 0$ with action functional

 $\mathcal{S}_T[\gamma] = \int_0^T \mathcal{L}(\gamma_t, \dot{\gamma}_t) dt$ for any $\gamma : [0, T] \longrightarrow \mathbb{R}^d$ abs. continuous on [0, T]

 $\gamma \left(-\frac{\mathcal{S}_T[\gamma] + \mathcal{O}(\varepsilon)}{2} \right)$ $\mathbb{P}(\mathsf{SGD} \text{ on } [0, T/\eta] \approx \gamma) = \exp(-\frac{1}{2})$

$$\begin{array}{l} \text{e} \text{):} \ Z(x;\omega) \sim N\big(0,\sigma^2 I_d\big), \ \mathcal{H}(x,v) = \frac{\sigma^2}{2} \|v\|^2 \ \text{and} \ \mathcal{L}(x,v) = \frac{\|v+\nabla f(x)\|^2}{2\sigma^2} \\ \\ \mathcal{S}_T[\gamma] = \frac{1}{2\sigma^2} \int_0^T \|\dot{\gamma}_t + \nabla f(\gamma_t)\|^2 dt \end{array}$$

(SGD transitions from
$$K_i$$
 to K_j) = exp $\left(-\frac{B_{i,j} + \mathcal{O}(\varepsilon)}{\eta}\right)$

$$B_{i,j} = \inf \big\{ \mathcal{S}_T[\gamma] \mid \gamma(0) \in K_i, \gamma(T) \in K_j, T \in \mathbb{N} \big\}$$

Transition graph: complete graph on $\{1, ..., p\}$ with weights $B_{i,j}$ on $i \rightarrow j$

$$E_i = \min \left\{ \sum_{j o k \in T} B_{j,k} \mid T \text{ spanning tree pointing to } i
ight\}$$

Given : $\varepsilon > 0$, \mathcal{U}_i neighborhoods of K_i , and $\eta > 0$ small enough, 1. Concentration on $\operatorname{crit}(f)$: there is some c > 0 s.t. $\mu_{\infty}\left(\bigcup_{i=1}^{p}\mathcal{U}_{i}\right)\geq1-e^{-\frac{c}{\eta}},$ for some c > 0 $\mu_{\infty}(\mathcal{U}_{i}) \propto \exp\left(-\frac{E_{i} + \mathcal{O}(\varepsilon)}{\eta}\right)$ 3. Avoidance of non-minimizers: if K_i is not minimizing, then there is K_i minimizing with $E_i < E_i$: $\frac{\mu_{\infty}(\mathcal{U}_{i})}{\mu_{\infty}(\mathcal{U}_{j})} \leq e^{-\frac{c_{i,j}}{\eta}}$ for some $c_{i,i} > 0$ 4. Concentration on ground states: given \mathcal{U}_0 neighborhood of the ground states $K_0 = \operatorname{argmin}_i E_i$, $\mu_{\infty}(\mathcal{U}_0) \geq 1 - e^{-\frac{c_0}{\eta}},$ for some $c_0 > 0$

Example (Gaussian noise): $E_i = \frac{f(x_i)}{2\sigma^2}$ for any $x_i \in K_i$